

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/618,532	CHIN ET AL.	
Examiner	Art Unit		
Saeed T. Chaudhry	1746		

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>